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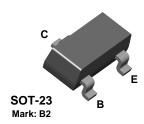
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Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (_), the underscore (_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.onsemi.com. Please email any questions regarding the system integration to Fairchild guestions@onsemi.com.

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BSV52



NPN Switching Transistor

This device is designed for high speed saturated switching at collector currents of 10 mA to 100 mA. Sourced from Process 21.

Absolute Maximum Ratings*

TA = 25°C unless otherwise noted

Symbol	Parameter	Value	Units	
V_{CEO}	Collector-Emitter Voltage	12	V	
V _{CES}	Collector-Base Voltage	20	V	
V _{EBO}	Emitter-Base Voltage	5.0	V	
I _C	Collector Current - Continuous	200	mA	
T _J , T _{stg}	Operating and Storage Junction Temperature Range	-55 to +150	°C	

^{*}These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

NOTES:

1) These ratings are based on a maximum junction temperature of 150 degrees C.

2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

Thermal Characteristics TA = 25°C unless otherwise noted

Symbol	Characteristic	Max	Units
		*BSV52	
P _D	Total Device Dissipation	225	mW
	Derate above 25°C	1.8	mW/°C
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	556	°C/W

^{*}Device mounted on FR-4 PCB 40 mm X 40 mm X 1.5 mm.

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(continued)

Symbol	Parameter	Test Conditions	Min	Max	Units
OFF CHA	RACTERISTICS				
$V_{(BR)CEO}$	Collector-Emitter Breakdown Voltage	$I_{\rm C} = 10 \text{ mA}, I_{\rm B} = 0$	12		V
V _{(BR)CES}	Collector-Base Breakdown Voltage	$I_C = 10 \mu A, I_E = 0$	20		V
V _{(BR)EBO}	Emitter-Base Breakdown Voltage	$I_E = 100 \mu A, I_C = 0$	5.0		V
I _{CBO}	Collector-Cutoff Current	$V_{CB} = 10 \text{ V}, I_{E} = 0$		100	nA
		$V_{CB} = 10 \text{ V}, I_E = 0, T_A = 125^{\circ}\text{C}$		5.0	μΑ
ON CHAR	RACTERISTICS				
h _{FE}	DC Current Gain	$I_C = 1.0 \text{ mA}, V_{CE} = 1.0 \text{ V}$	25		
		$I_C = 10 \text{ mA}, V_{CE} = 1.0 \text{ V}$	40	120	
		$I_C = 50 \text{ mA}, V_{CE} = 1.0 \text{ V}$	25		
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$I_{\rm C} = 10 \text{ mA}, I_{\rm B} = 0.3 \text{ mA}$		0.3	V
		$I_C = 10 \text{ mA}, I_B = 1.0 \text{ mA}$		0.25	V
\ /	Base-Emitter Saturation Voltage	$I_C = 50 \text{ mA}, I_B = 5.0 \text{ mA}$ $I_C = 10 \text{ mA}, I_B = 1.0 \text{ mA}$	0.7	0.4	V
$V_{BE(sat)}$	base-Emilier Saturation voltage	$I_C = 10 \text{ mA}, I_B = 1.0 \text{ mA}$ $I_C = 50 \text{ mA}, I_B = 5.0 \text{ mA}$	0.7	1.2	V
	L	.с ос , .в осе с			<u> </u>
SMALL SI	GNAL CHARACTERISTICS				
	Transition Frequency	$I_C = 10 \text{ mA}, V_{CE} = 10 \text{ V},$	400		MHz
f _T	. Tanonion i roquenoy	f = 100 MHz			
	Collector-Base Capacitance	, 52		4.0	pF
C _{cb}	·	f = 100 MHz		4.0 4.5	pF pF
C _{cb}	Collector-Base Capacitance	f = 100 MHz I _E = 0, V _{CB} = 5.0 V, f = 1.0 MHz			
C _{cb}	Collector-Base Capacitance	f = 100 MHz I _E = 0, V _{CB} = 5.0 V, f = 1.0 MHz			
C _{cb} C _{eb}	Collector-Base Capacitance Emitter-Base Capacitance	f = 100 MHz I _E = 0, V _{CB} = 5.0 V, f = 1.0 MHz			
C _{cb} C _{eb} SWITCHIN	Collector-Base Capacitance Emitter-Base Capacitance	$\begin{split} &f = 100 \text{ MHz} \\ &I_E = 0, V_{CB} = 5.0 \text{ V}, f = 1.0 \text{ MHz} \\ &I_C = 0, V_{EB} = 1.0 \text{ V}, f = 1.0 \text{ MHz} \\ \\ &I_{B1} = I_{B2} = I_C = 10 \text{ mA} \\ &V_{CC} = 3.0 \text{ V}, I_C = 10 \text{ mA}, \end{split}$		4.5	pF
fr C _{cb} C _{eb} SWITCHIN ts ton	Collector-Base Capacitance Emitter-Base Capacitance NG CHARACTERISTICS Storage Time	$\begin{split} &f = 100 \text{ MHz} \\ &I_E = 0, V_{CB} = 5.0 \text{ V}, f = 1.0 \text{ MHz} \\ &I_C = 0, V_{EB} = 1.0 \text{ V}, f = 1.0 \text{ MHz} \\ \end{split}$		4.5	pF

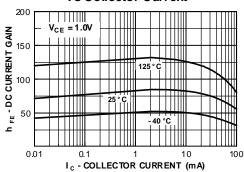
Spice Model

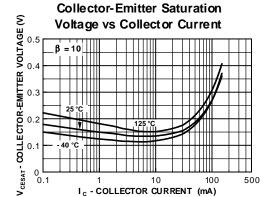
 $NPN \ (Is=44.14f \ Xti=3 \ Eg=1.11 \ Vaf=100 \ Bf=78.32 \ Ne=1.389 \ Ise=91.95f \ Ikf=.3498 \ Xtb=1.5 \ Br=12.69m \ Nc=2 \ Isc=0 \ Ikr=0 \ Rc=.6 \ Cjc=2.83p \ Mjc=86.19m \ Vjc=.75 \ Fc=.5 \ Cje=4.5p \ Mje=.2418 \ Vje=.75 \ Tr=1.073u \ Tf=227.6p \ Itf=.3 \ Vtf=4 \ Xtf=4 \ Rb=10)$

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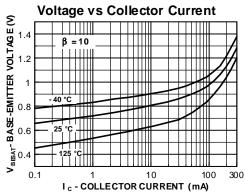
Typical Characteristics





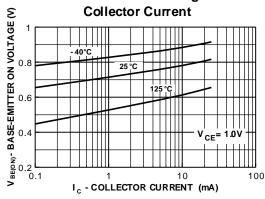


Base-Emitter Saturation



Base-Emitter ON Voltage vs

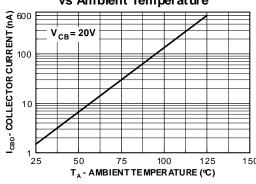
I C - COLLECTOR CURRENT (mA)



Collector-Cutoff Current vs Ambient Temperature

0.1

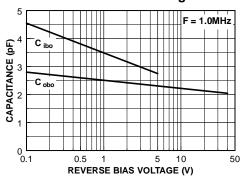
0.1



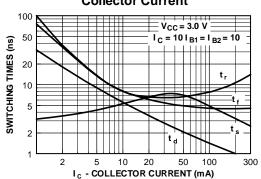
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Typical Characteristics (continued)

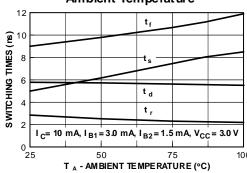




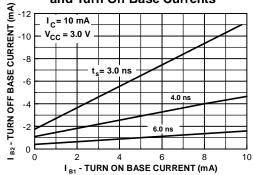
Switching Times vs Collector Current



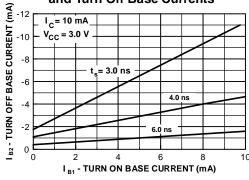
Switching Times vs Ambient Temperature



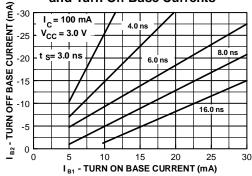
Storage Time vs Turn On and Turn Off Base Currents



Storage Time vs Turn On and Turn Off Base Currents

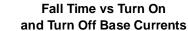


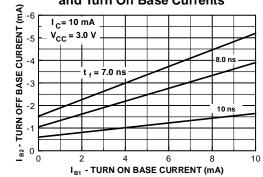
Storage Time vs Turn On and Turn Off Base Currents



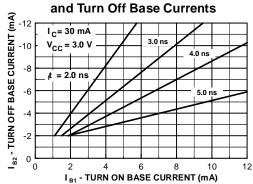
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Typical Characteristics (continued)

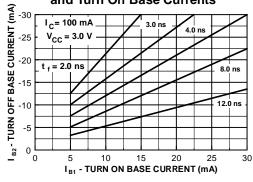




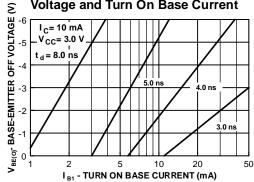
Fall Time vs Turn On



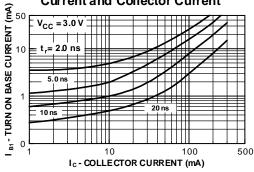
Fall Time vs Turn On and Turn Off Base Currents



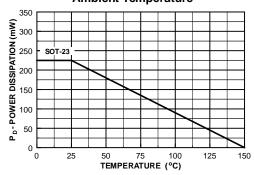
Delay Time vs Base-Emitter OFF Voltage and Turn On Base Current



Rise Time vs. Turn On Base Current and Collector Current



Power Dissipation vs Ambient Temperature



(continued)

Test Circuits

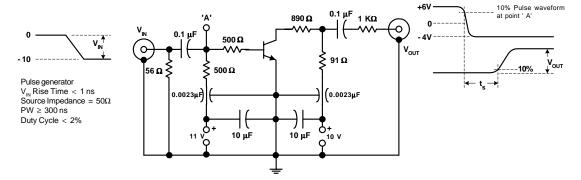


FIGURE 1: Charge Storage Time Measurement Circuit

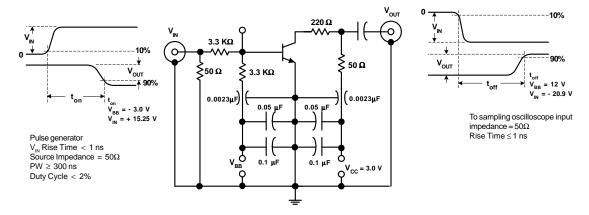


FIGURE 2: $\mathbf{t}_{\text{ON}}, \mathbf{t}_{\text{OFF}}$ Measurement Circuit

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